

Resource Summary Report

Generated by [NIF](#) on Sep 12, 2026

FEI: Phenom Pro Desktop SEM

RRID:SCR_019902

Type: Tool

Proper Citation

FEI: Phenom Pro Desktop SEM (RRID:SCR_019902)

Resource Information

URL: <https://www.fei.com/products/sem/phenom-pro/>

Proper Citation: FEI: Phenom Pro Desktop SEM (RRID:SCR_019902)

Description: Desktop scanning electron microscope with CeB6 source that offers high brightness while requiring low maintenance. It allows sample structures to be physically examined and their elemental composition determined.

Resource Type: instrument resource

Keywords: FEI, SEM, Instrument Equipment, USEDit,

Availability: Commercially available

Resource Name: FEI: Phenom Pro Desktop SEM

Resource ID: SCR_019902

Alternate IDs: Model_Number_Phenom Pro

Record Creation Time: 20220129T080347+0000

Record Last Update: 20260912T195925+0000

Ratings and Alerts

No rating or validation information has been found for FEI: Phenom Pro Desktop SEM.

No alerts have been found for FEI: Phenom Pro Desktop SEM.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.